

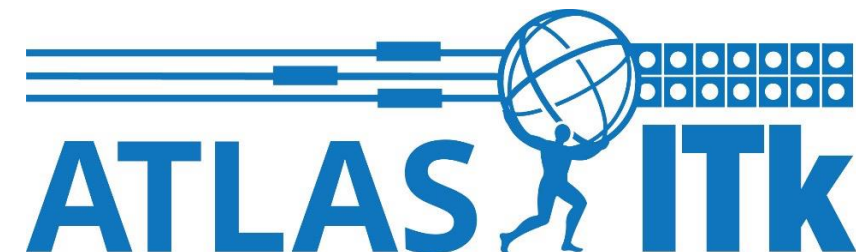
# Qualification of pixel detectors for the upgrade of the ATLAS Inner Detector with beam tests

**Juan Ignacio Carlotto**

On behalf of ATLAS ITk

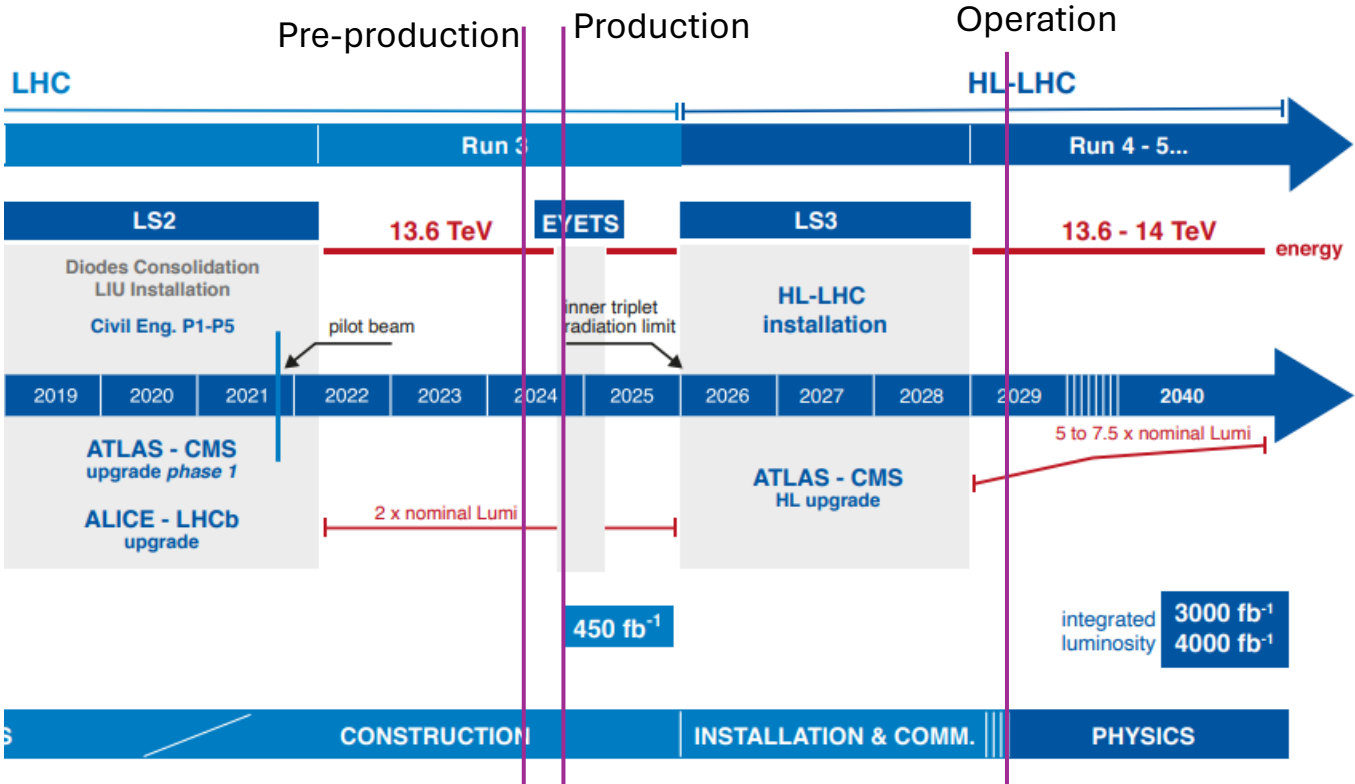
**BTTB12 Workshop Edinburgh**

15–19 april 2024



# Large Hadron Collider upgrade

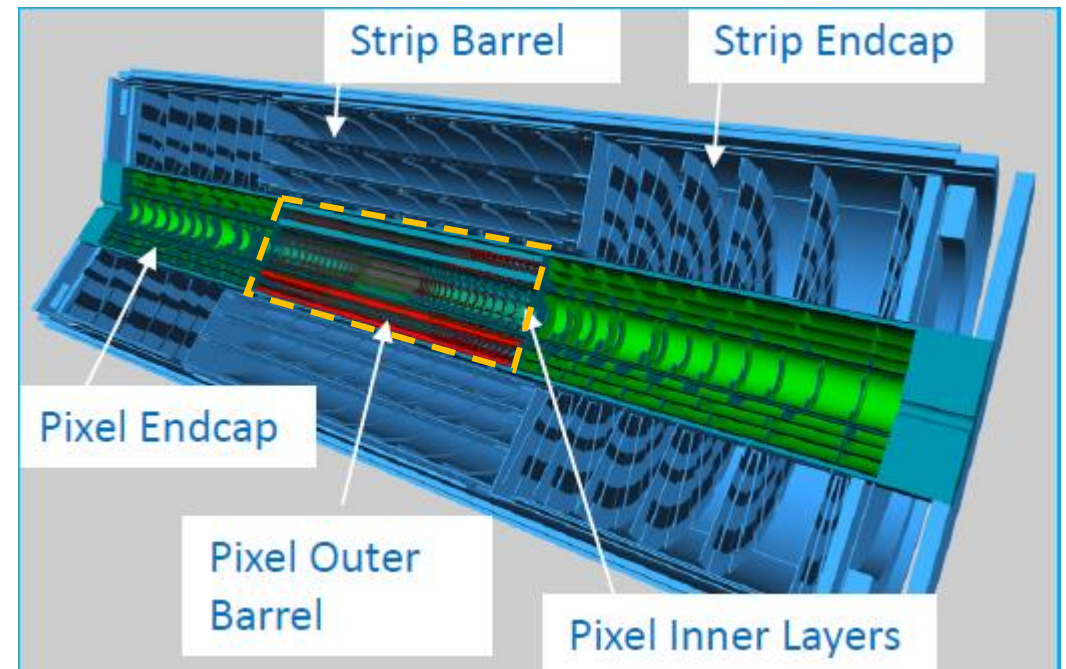
- The LHC next upgrade is the High-Luminosity LHC (HL-LHC) planned to start operation in 2029.
- It is expected to provide up to 200 proton-proton interaction per bunch crossing delivering about 4000 fb<sup>-1</sup> of data over 10 years.
- An upgrade of the ATLAS detector is needed to cope with the harsher radiation levels and with a much higher number of tracks.



# ATLAS ITk upgrade

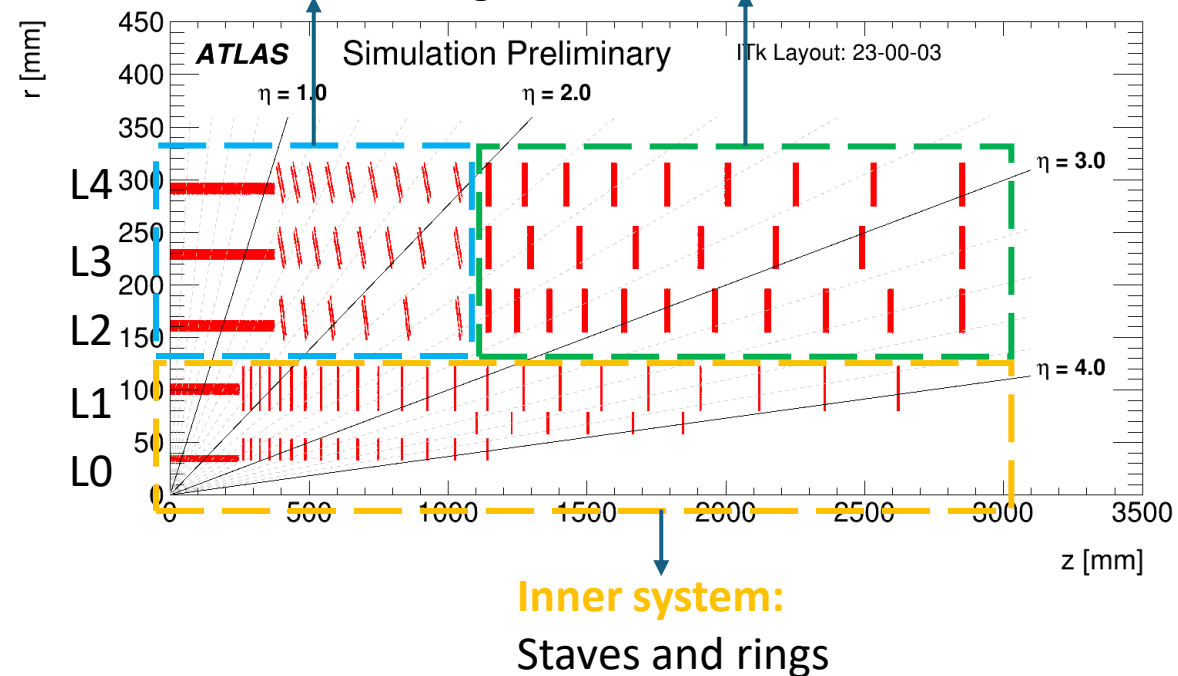
The ATLAS Inner Detector will be completely replaced with an all-silicon Inner Tracker (ITk). The challenges for this new detector are related to:

- **Large number of tracks**
  - High pixel granularity (small pitch)
- **High radiation levels**
  - Improved radiation hardness



**Outer barrel:** Staves and inclined rings

**Outer EndCap:** Rings



Left picture shows a schematic depiction of the ITk Layout,

- 5 layers
  - 3D pixel sensors for the innermost layer (L0)
  - n-in-p planar silicon sensors for the other layers

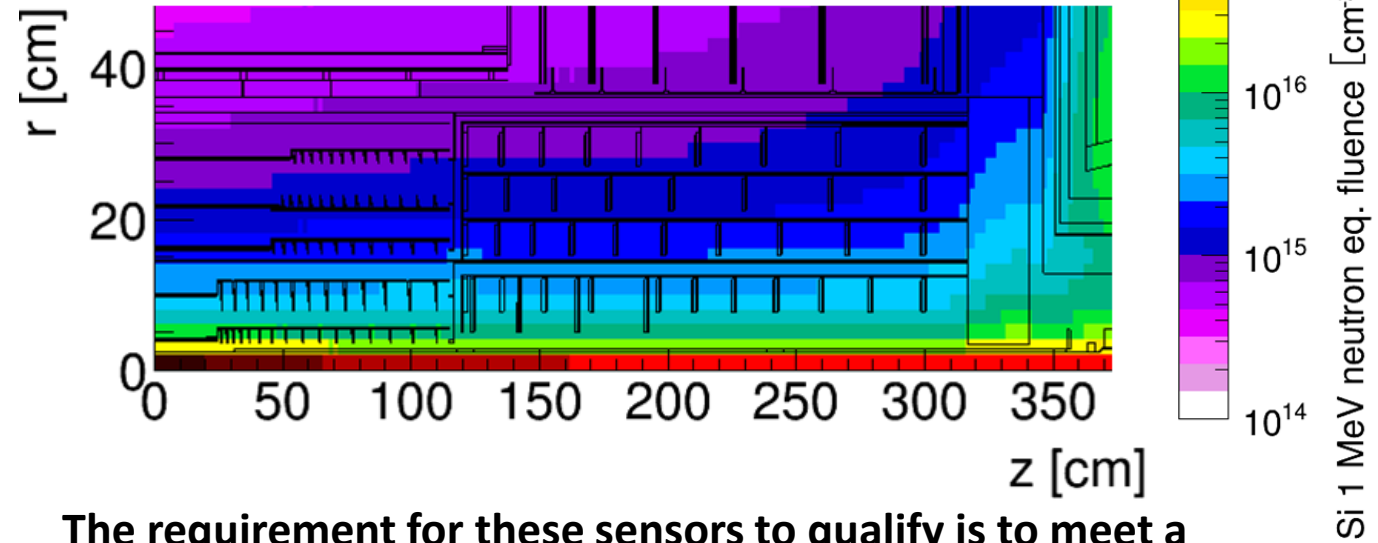
# ATLAS ITk upgrade

Radiation expected during the full sensor operation life:

- Inner system:  $1.7 \cdot 10^{16} n_{eq}/cm^2$
- Outer system:  $5 \cdot 10^{15} n_{eq}/cm^2$

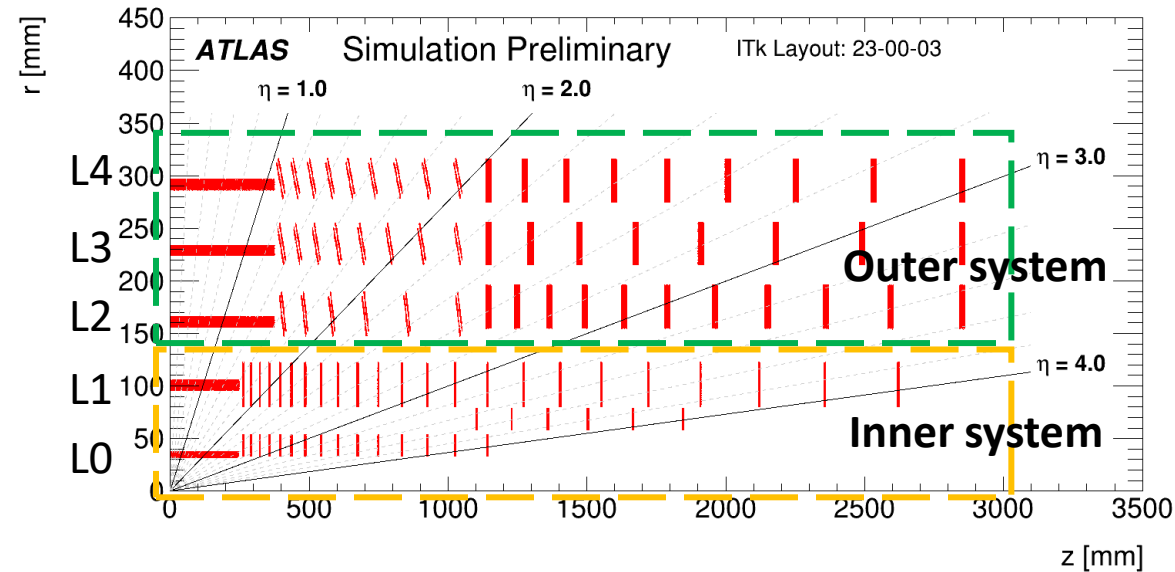
Performance of pre-production sensors irradiated at these fluences going to be presented.

Simulation of radiation expected for HL-LHC ATLAS detector



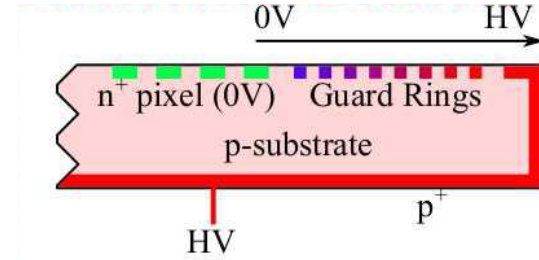
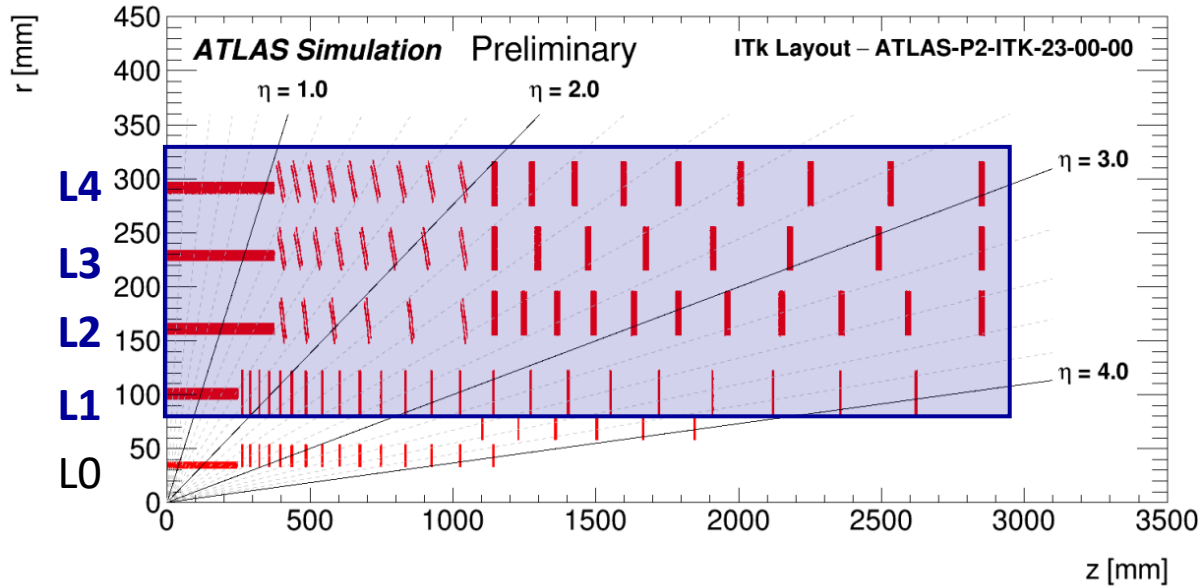
The requirement for these sensors to qualify is to meet a detection efficiency:

- For 3D pixel sensor (L0 layer):
  - Higher than 96% at perpendicular configuration or 97% at tilted configuration (see slide 9) after being irradiated at  $1.7 \cdot 10^{16} n_{eq}/cm^2$
- For planar sensors (L1-L4 layers):
  - Higher than 97% after being irradiated at  $5 \cdot 10^{15} n_{eq}/cm^2$



It is expected that the ITk pixel Inner system will be replaced after 5 years of operation because of the radiation damage.

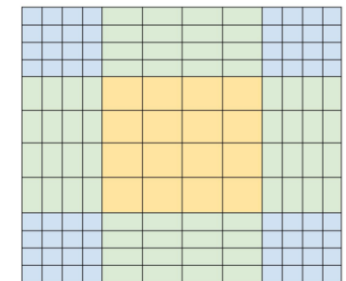
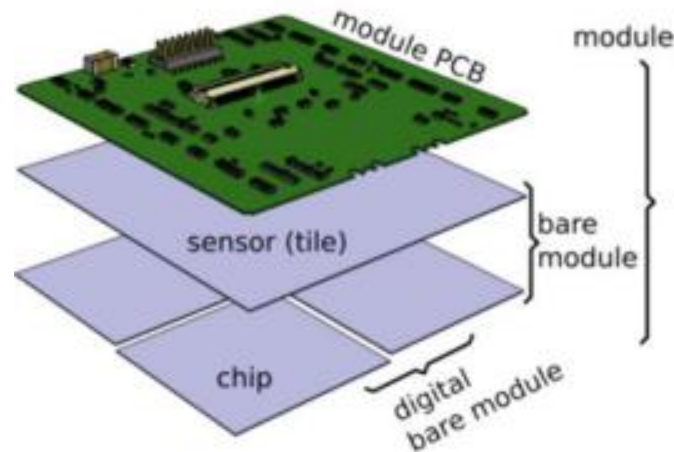
# ITk planar sensors – quad module



- Single side process with guardring and pixels on the top side
- Parylene protection
  - Reinforce bonds and avoid corrosion
  - Prevent discharge between sensor and front-end
- The centre of the quad sensor has larger pixels with different geometries to extend the coverage of the sensor into the inter-chip gap

ITk pixel detector is composed by different layers:

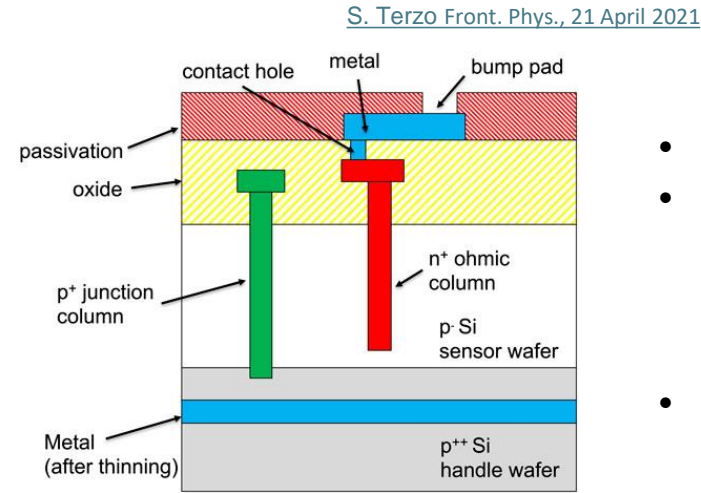
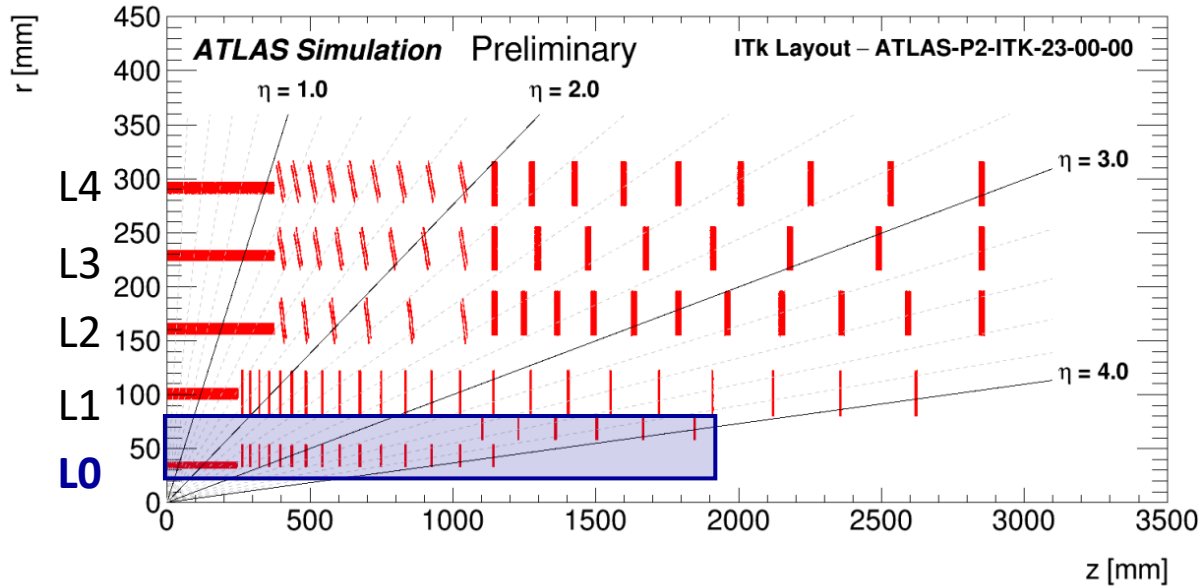
- **L1: Inner system**
  - Staves and rings
    - 50x50  $\mu\text{m}^2$  pixel planar sensors **100  $\mu\text{m}$**  active thickness.
- **L2-L4: Outer system**
  - Stave and rings
    - 50x50  $\mu\text{m}^2$  pixel planar sensors **150  $\mu\text{m}$**  active thickness.



- Pixel size
- 50x50  $\mu\text{m}^2$
  - 100x100  $\mu\text{m}^2$
  - 50x100  $\mu\text{m}^2$  or 100x50  $\mu\text{m}^2$



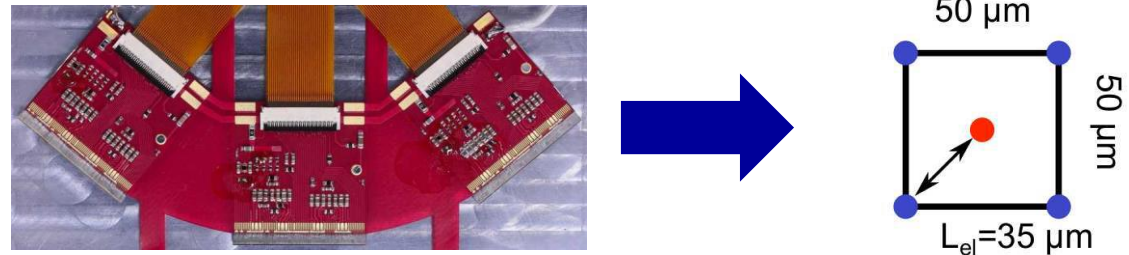
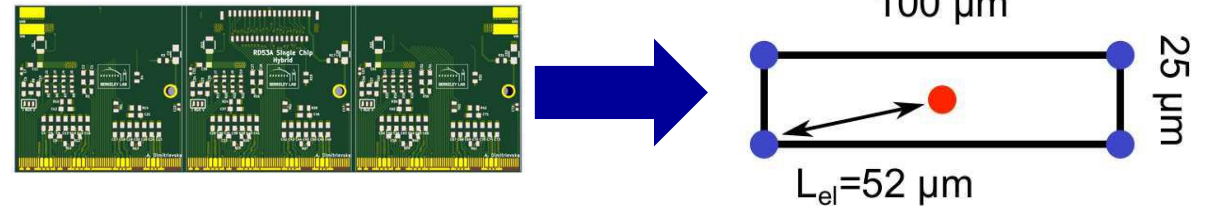
# ITk 3D pixel sensors – triplet module



- Single side process
- Single read-out electrode in the center (n+ column) and four bias electrodes (p+ columns) at the corners
- Two different configurations

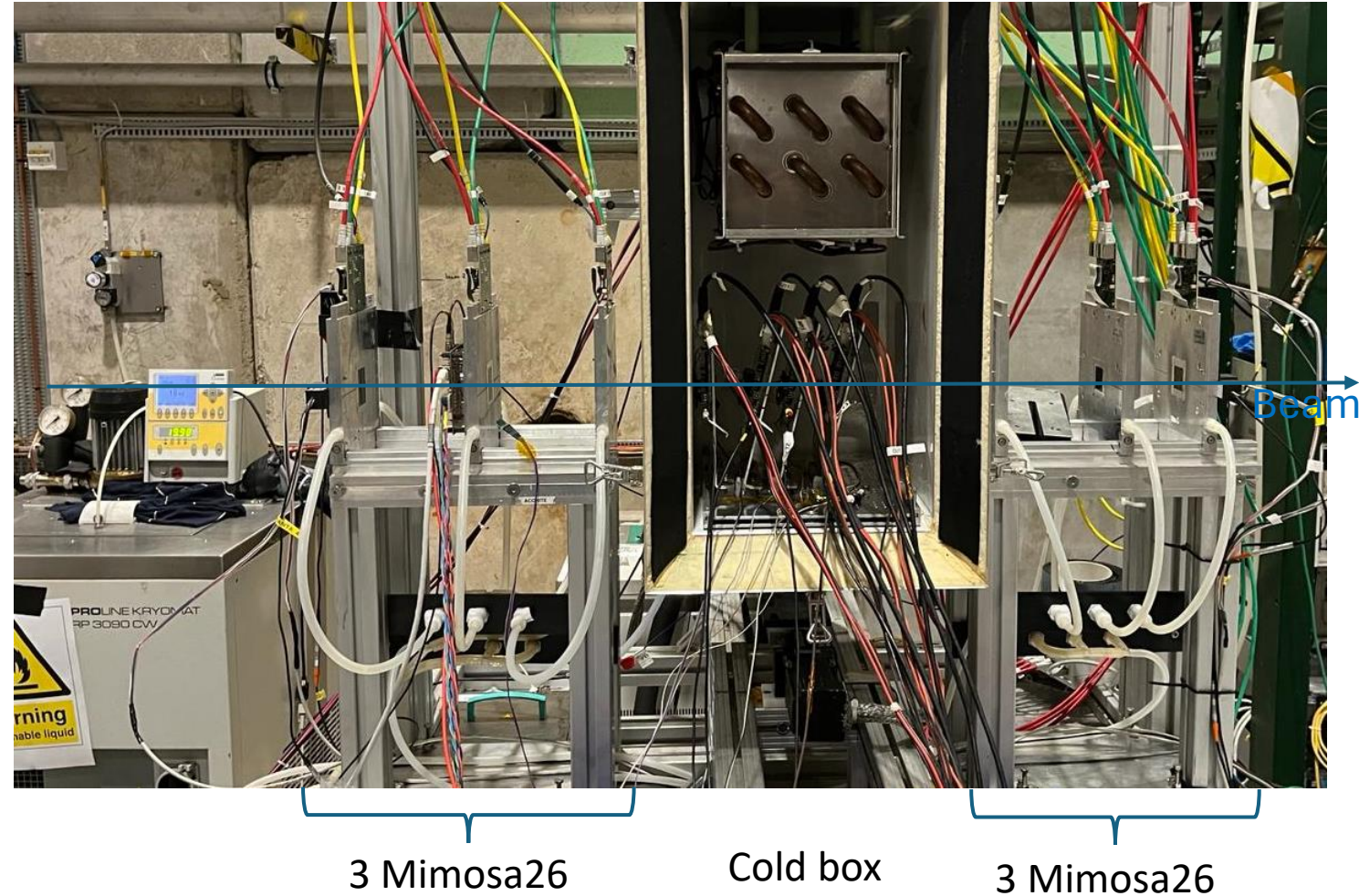
ITk pixel detector is composed by different layers:

- **L0: Inner most system**
  - **Staves: Linear triplets**
    - 25x100  $\mu\text{m}^2$  3D pixel sensors with 1 electrode and **150  $\mu\text{m}$**  active thickness.
  - **Rings: Rings triplets**
    - 50x50  $\mu\text{m}^2$  3D pixel sensors with 1 electrode and **150  $\mu\text{m}$**  active thickness.
  - **Very high radiation hardness**



# Testbeam setup at SPS-CERN

- EUDET telescope with 6 Mimosa26 planes and trigger scintillators
- FE-I4 (MMC3 readout) plane and single ITkPixV1.1 (FBK 3D sensor) for track matching.
- Results were obtained using ITkPixV1.1 chip.
- 120 GeV pions
- Cold box: 2 deep temperature chillers driving external cooling circuits with silicon oil / ethanol:
  - Liquid/air heat exchanger inside the box
  - Additional cooling circuit only for quads
  - Pre-colling nitrogen (for humidity control)

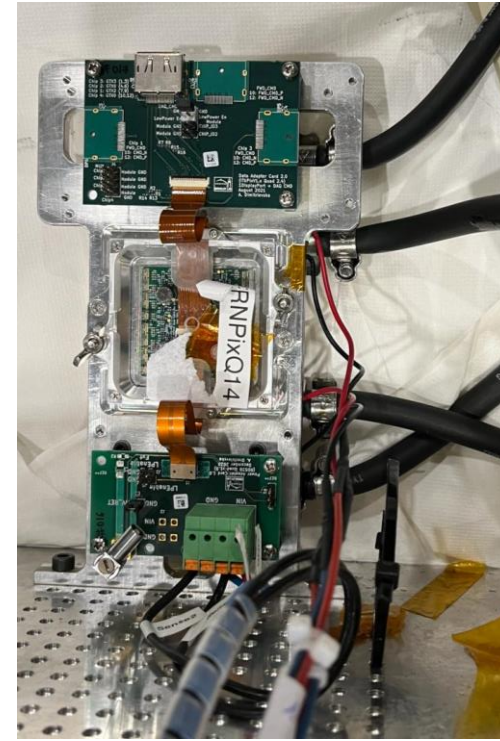
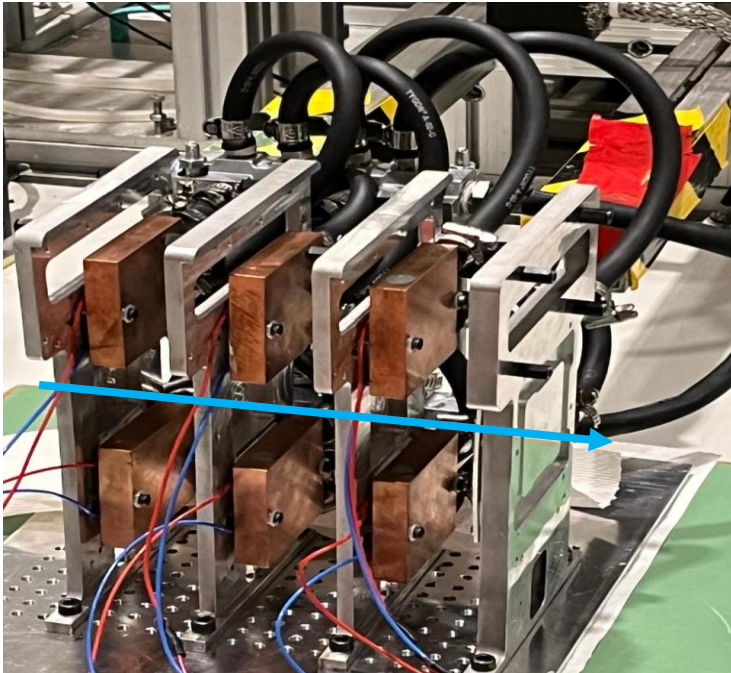




# Testbeam setup at SPS-CERN

## Quad module setup

- Challenging cooling system for quads.
  - Additional cooling circuit only for quads with ethanol or silicon oil.
  - no material is added along beam's track
- Achieved  $< -15\text{ }^{\circ}\text{C}$  on powered quad modules



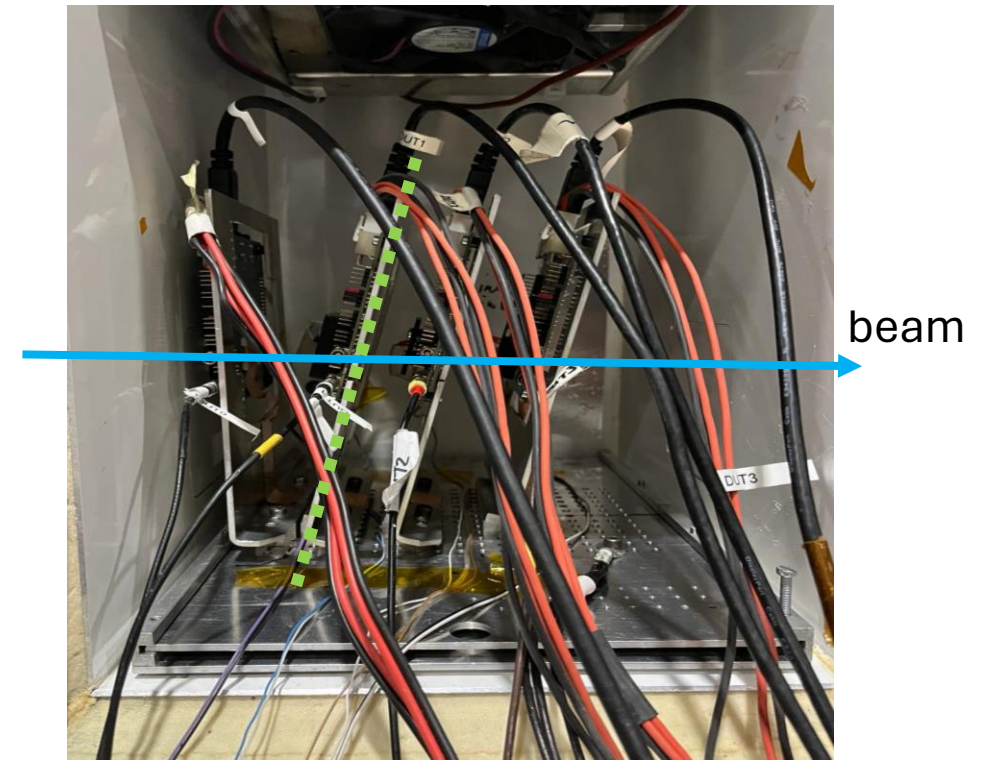
- A special frame was fabricated to support the quad in the center.
- Data adapter and power cards are located from the top and bottom connected to the module pcb by pigtailed.
- The holder is directly cooled down by two Peltiers (above and below the module), each cooled down by a copper heat exchanger cooled with silicon oil/ethanol.
- **No material is added along beam's track to achieve the cooling**



# Testbeam setup at SPS-CERN

## 3D pixel setup

- 3D modules mounted on rigid PCB (single chip card, SCC) intended for testing individual bare module.
- Measurements were performed at different configuration angles:
  - 0° (perpendicular )
  - 15° (To avoid column effects)
- **Reconstruction of the events with Corryvreckan**
  - Introduce geometry of the experiment:
    - Position and inclination of the detectors
    - Pixel dimensions.
      - Default value was  $50 \times 50 \mu\text{m}^2$
      - It was necessary to modify the program to adjust to  $25 \times 100 \mu\text{m}^2$
  - DUT clusters are also requested to match the expected position by tracks



# Modules tested during 2022/2023 testbeam

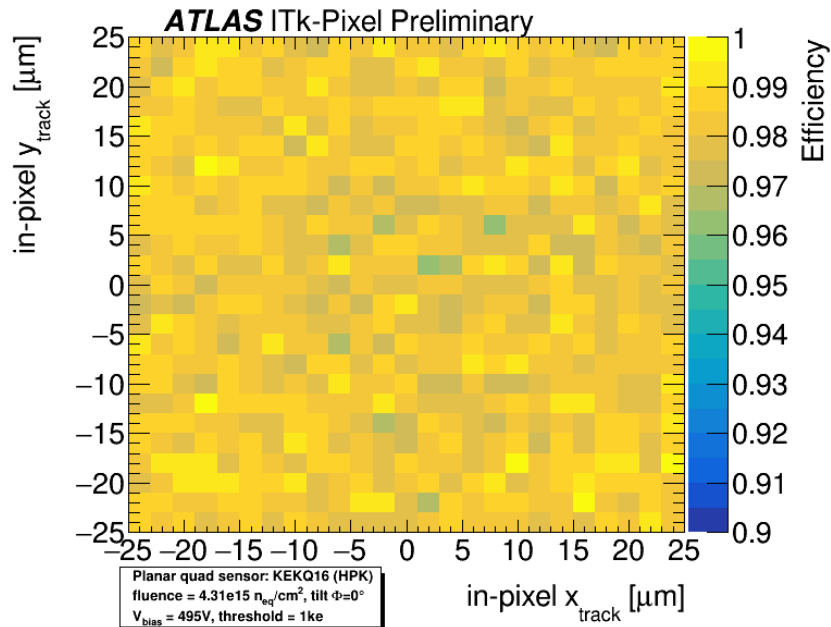
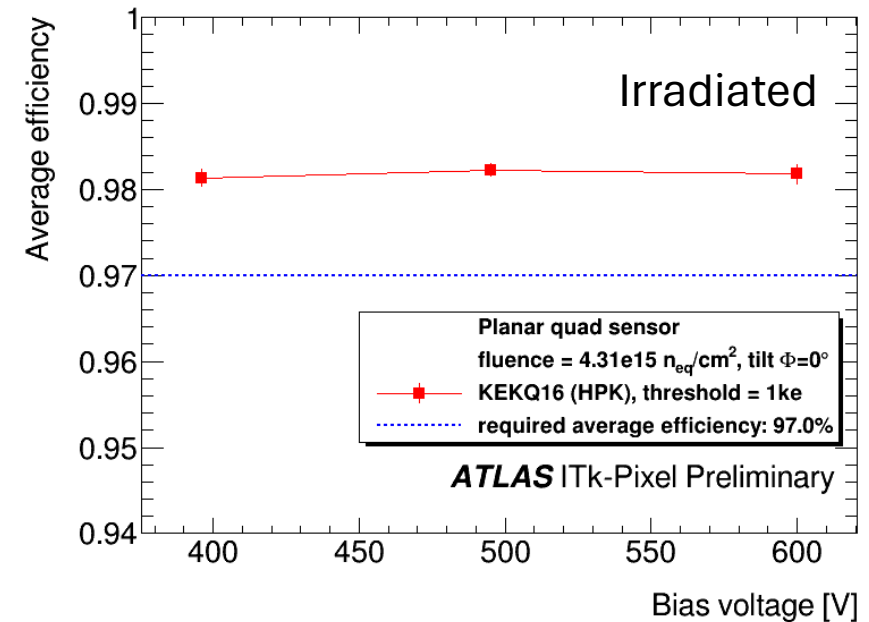
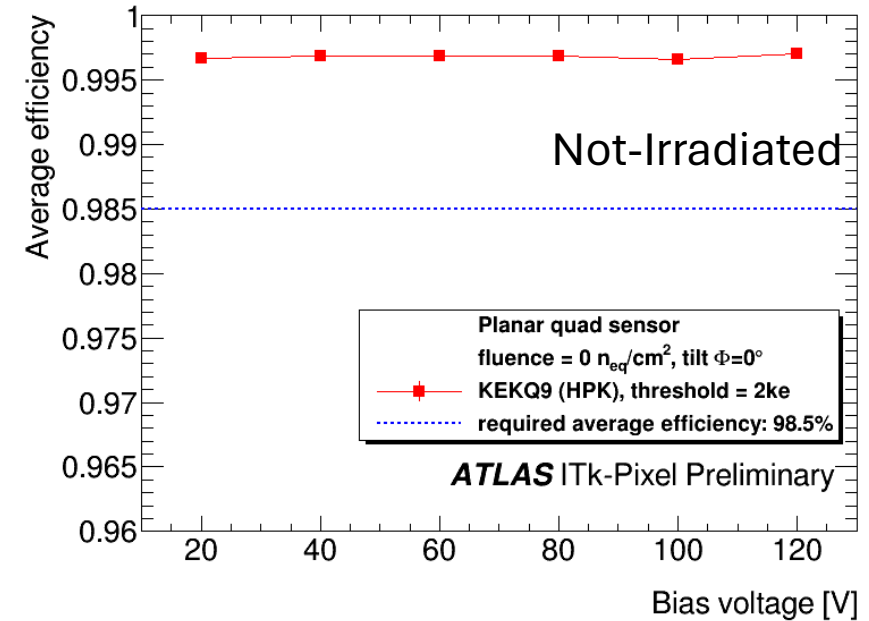
- Pre-production sensors were irradiated at:
  - KIT (23 MeV protons)
  - CERN IRRAD (24 GeV protons)
  - CYRIC (70 MeV protons)
  - Bonn (13 MeV protons)
- List of modules tested presented in this presentation:

| Sensor   | Manufacture place | Pixel dimension [ $\mu\text{m}^2$ ] | Serial Number | Irradiation level [ $10^{16}n_{\text{eq}}/\text{cm}^2$ ] | Place of irradiation |
|----------|-------------------|-------------------------------------|---------------|--|----------------------|
| 3D pixel | SINTEF            | 50x50                               | 1S            | 1  | KIT                  |
|          |                   |                                     | 4S            | 1.8 (not uniform)  | KIT+IRRAD            |
|          | FBK               | 25x100                              | SCC29         | 1  | KIT                  |
|          |                   |                                     | SCC23         | 2.4 (not uniform)  | IRRAD                |
|          |                   |                                     | SCC24         | 2.3 (not uniform)  | IRRAD                |
|          |                   |                                     | 50x50         | SCC3   | 1.7 (not uniform)    |
|          | Planar            | HPK                                 | 50x50         | KEKQ9  | -                    |
| KEKQ16   |                   |                                     |               | 0.43   | CYRIC                |

Planar sensor from FBK and Micron (100  $\mu\text{m}$  and 150  $\mu\text{m}$ ) were tested but analysis is still in process.

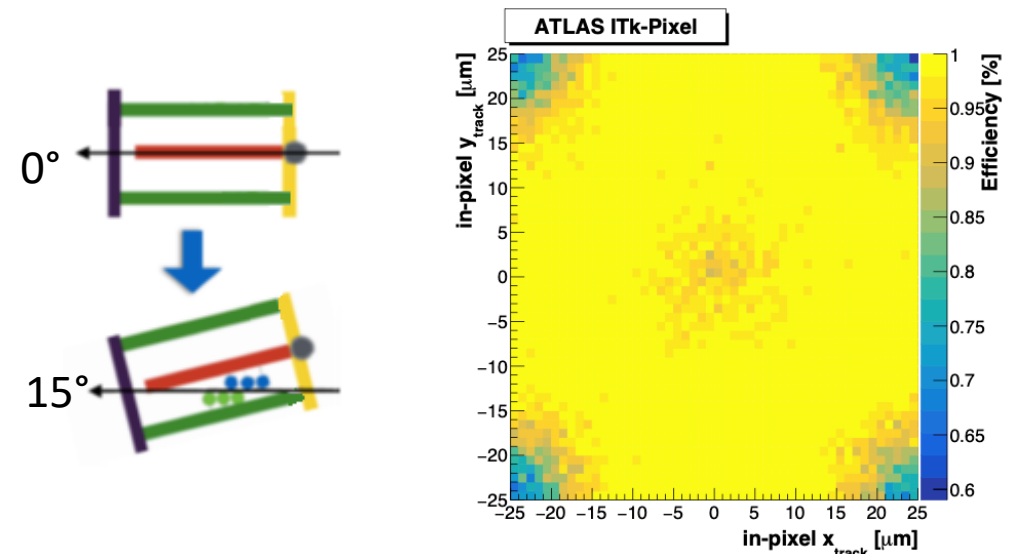
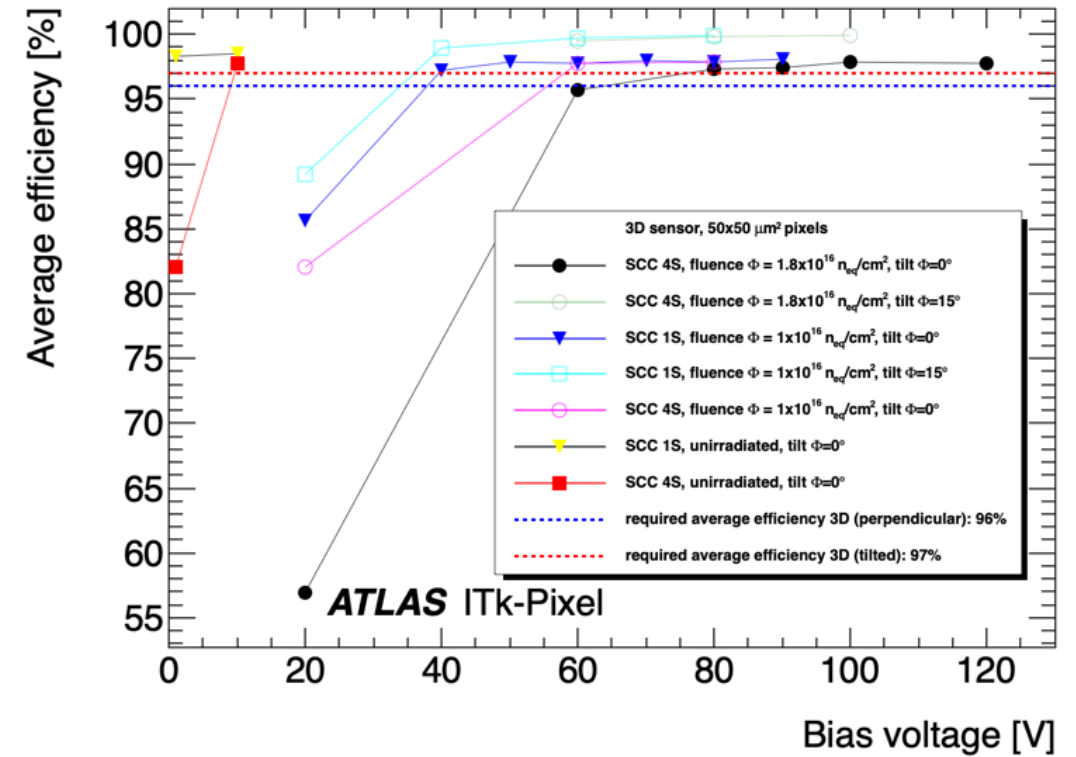
# HPK planar sensor

- 2 HPK 50x50  $\mu\text{m}^2$  planar sensors were tested:
  - KEKQ9 (not irradiated)
  - KEKQ16 (irradiated up to  $4.3 \cdot 10^{15} \text{ n}_{\text{eq}}/\text{cm}^2$ )
- KEKQ9 reaches the 98.5% hit efficiency at 20 V.
- While KEKQ16 reaches the 97% (requirement for irradiated sensors) at 400 V.



# SINTEF 3D pixel Sensors

- 2 SINTEF 3D 50x50  $\mu\text{m}^2$  pixel sensors were tested in different conditions:
  - Fluences
    - Unirradiated;  $1 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  and  $1.8 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$
  - Angles
    - $0^\circ$  (perpendicular) and  $15^\circ$
- Hit efficiency specifications is reached at  $1.8 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  on both angles.
  - 97% ( $15^\circ$ ) at 60 V
  - 96% (perpendicular) at 80 V
- Hit efficiency in the perpendicular configuration.
  - The hit efficiency is lower in the corners and the center of the pixel cell because of the columns



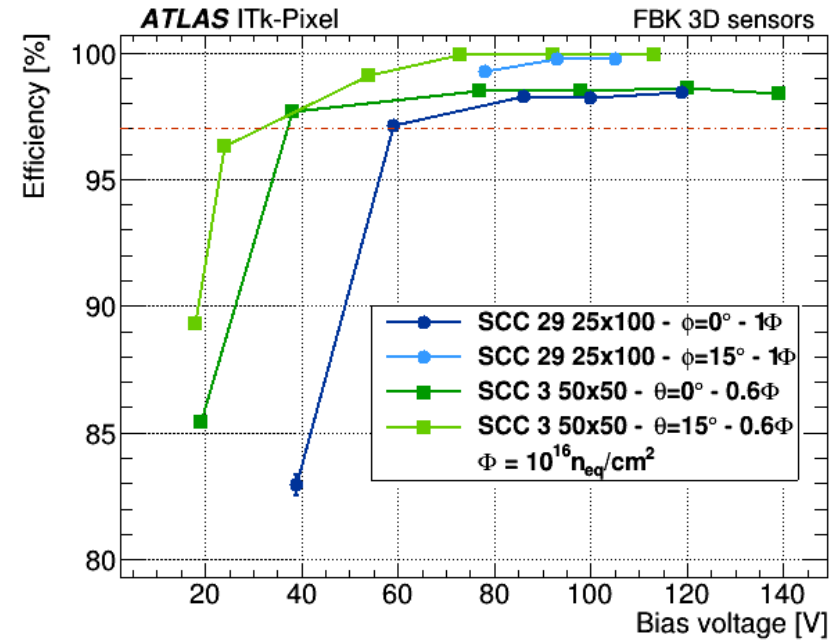


# FBK 3D pixel Sensors

3D FBK 50x50

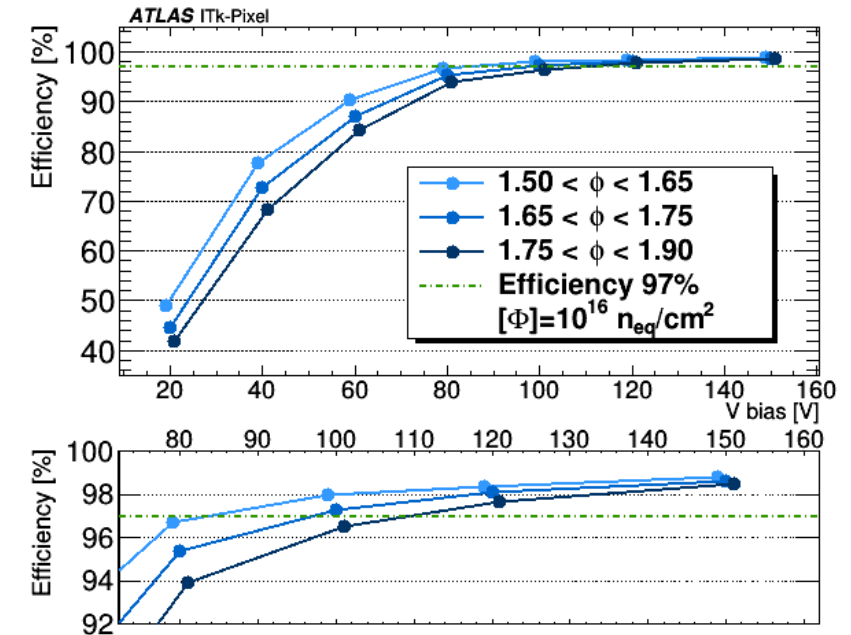
## Upper picture:

- Hit efficiency plot for SCC29 (25x100  $\mu\text{m}^2$ ) and SCC3 (50x50  $\mu\text{m}^2$ ) perpendicular and inclined configuration.
- At  $1 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  fluence both reached the 97% hit efficiency required at 60 V.



## Bottom picture:

- 3D FBK 50x50  $\mu\text{m}^2$  measured at target fluences in 2022 and 2023 Irradiated at IRRAD (not uniform irradiation)
- Efficiency reached 97% at  $1.7 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  with the 3% of disabled pixels at 130 V.



# FBK 3D pixel Sensors

## Upper picture:

- The irradiation fluency level in the SCC24 25x100  $\mu\text{m}^2$  to max.  $2.4 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  (mean  $1.7 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$ ), similar results for SCC23.
- Picture shows the area where the testbeam experiment data was taken.

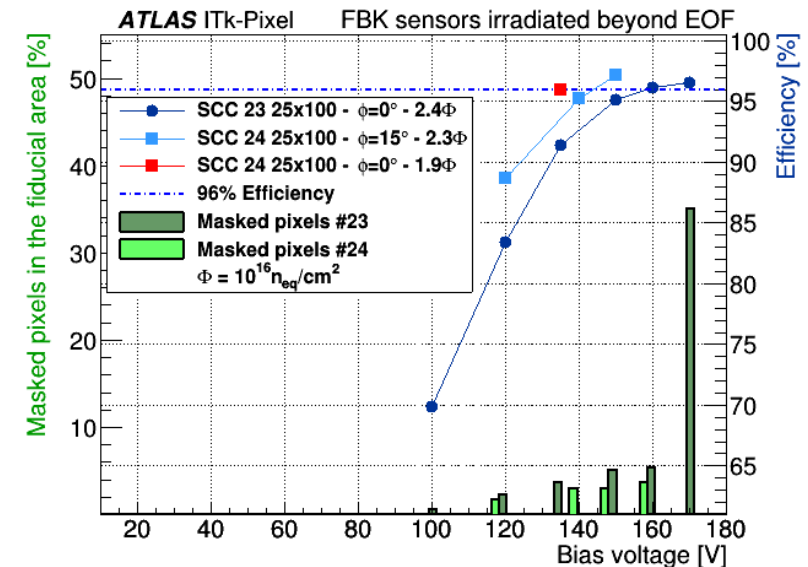
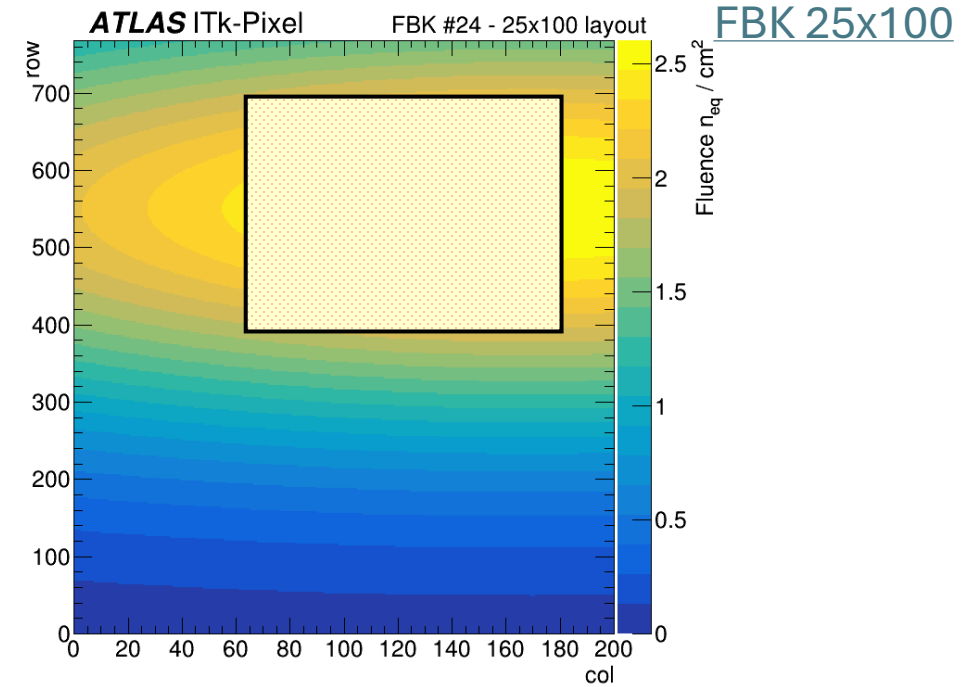
## Bottom picture:

### Hit efficiency results

- SCC23: Efficiency reaches 96% (normal incidence) even after irradiation at  $2.5 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  although with the 5% of disabled pixels at 160V that rapidly increasing at higher  $V_{\text{bias}}$ .
- SCC24: Efficiency is close to 97% (inclined) in the area with mean fluence around  $1.9 \cdot 10^{16} n_{\text{eq}}/\text{cm}^2$  with the 3% of disabled pixel at 150 V.

Beyond EOL

Further uniform irradiation of 25x100 3D pixel sensor is planner

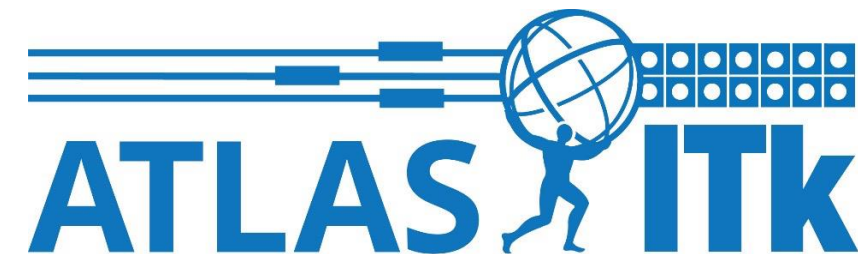


High number of dissable pixel because the radiation damage

# Conclusion

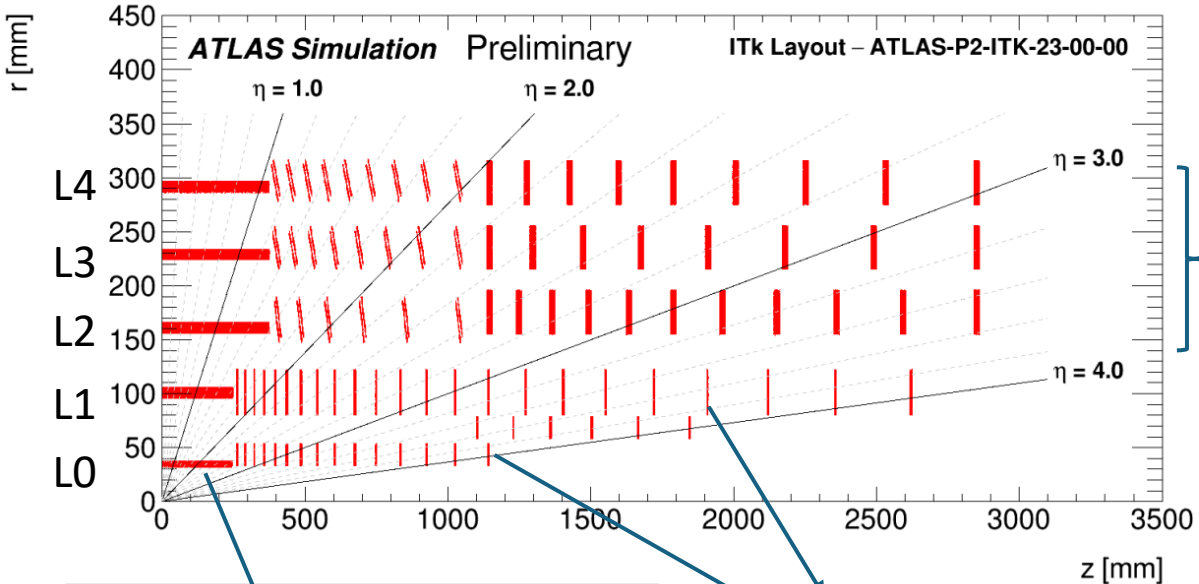
- Verification of the detection efficiency performance of the pre-production sensors was presented.
  - SINTEF 3D pixel sensor 50x50
  - FBK 3D pixel sensor 50x50 and 25x100
  - HPK 50x50 planar sensor
- 3D pixel and planar sensors meet the specifications at the corresponding irradiation fluence.
- New test beam campaign in 2024 for more measurements to confirm results, to test remaining vendor/module type combinations, to test first modules with the final chip ITkPixV2.

**Thank you for your  
attention**

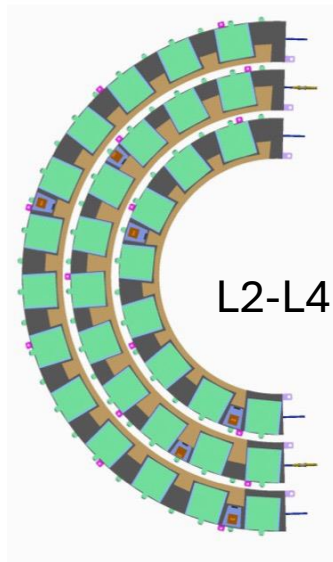
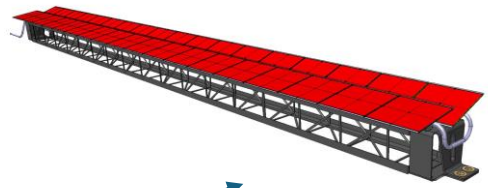




# ATLAS ITk configuration

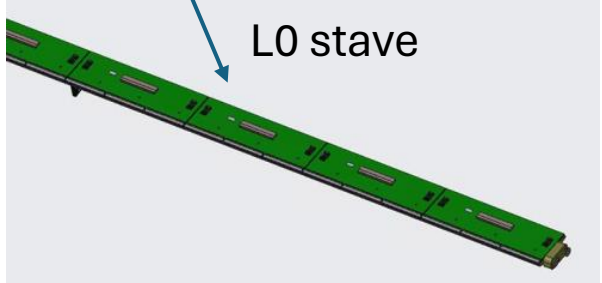


L2-L4 OB quad staves

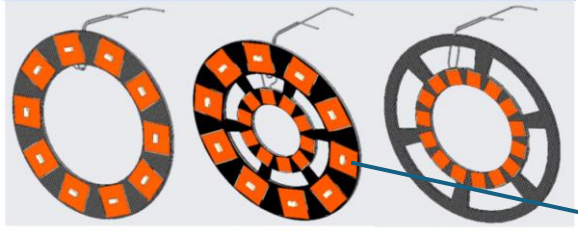


L2-L4 EC rings

L2-L4 OB rings



L0 stave



Ring module  
3 bare modules on 1 pcb

Quad module:  
4 planar sensors bump bonded to 1 FE glued to 1 PCB

Linear module:  
3 bare modules on 1 pcb

